Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/630,173	CHUEY, MARK D.
Examiner	Art Unit
Matsuichiro Shimizu	2635

	SEARCHED Subclass Date Examiner						
SEARCHED							
Class	Subclass	Date	Examiner				
340	825.72	6/5/06	ns				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
340	825.72	6/5/06	no		
-1	,	, ,			
-					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Fast or 340 While bus electronic	6/5/06	ao		